



FUKUCOM COMPANY LTD.

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FLAT P, 3/F, EVEREST INDUSTRIAL CENTRE, 396 KWUN TONG ROAD,
KWUN TONG, KOWLOON, HONG KONG.
TEL: 2790-0314 FAX: 2790-0206

FAIRCHILD
SEMICONDUCTOR®

November 2001

IRF840B/IRFS840B

IRF840B/IRFS840B 500V N-Channel MOSFET

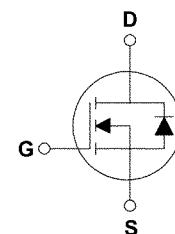
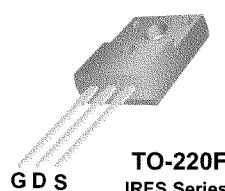
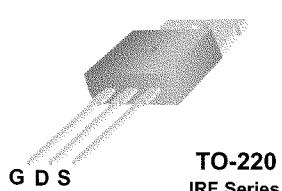
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supplies, power factor correction and electronic lamp ballasts based on half bridge.

Features

- 8.0A, 500V, $R_{DS(on)} = 0.8\Omega$ @ $V_{GS} = 10\text{ V}$
- Low gate charge (typical 41 nC)
- Low Crss (typical 35 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	IRF840B	IRFS840B	Units
V_{DSS}	Drain-Source Voltage	500		V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$)	8.0	8.0	A
	- Continuous ($T_C = 100^\circ\text{C}$)	5.1	5.1	A
I_{DM}	Drain Current - Pulsed	(Note 1)	32	A
V_{GSS}	Gate-Source Voltage		± 30	V
E_{AS}	Single Pulsed Avalanche Energy	(Note 2)	320	mJ
I_{AR}	Avalanche Current	(Note 1)	8.0	A
E_{AR}	Repetitive Avalanche Energy	(Note 1)	13.4	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	3.5	V/ns
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	134	44	W
	- Derate above 25°C	1.08	0.35	W/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	$^\circ\text{C}$

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	IRF840B	IRFS840B	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case Max.	0.93	2.86	$^\circ\text{C}/\text{W}$
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	--	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient Max.	62.5	62.5	$^\circ\text{C}/\text{W}$



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|IRF840B/IRFS840B

Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	500	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C	--	0.55	--	$\text{V}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 500 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	10	μA
$V_{\text{DS}} = 400 \text{ V}, T_C = 125^\circ\text{C}$			--	--	100	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	2.0	--	4.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 4.0 \text{ A}$	--	0.65	0.8	Ω
g_{FS}	Forward Transconductance	$V_{\text{DS}} = 40 \text{ V}, I_D = 4.0 \text{ A}$	(Note 4)	--	7.3	S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	1400	1800	pF
C_{oss}	Output Capacitance		--	145	190	pF
C_{rss}	Reverse Transfer Capacitance		--	35	45	pF

Switching Characteristics

$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 250 \text{ V}, I_D = 8.0 \text{ A}, R_G = 25 \Omega$	--	22	55	ns
t_r	Turn-On Rise Time		--	65	140	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	125	260	ns
t_f	Turn-Off Fall Time	(Note 4, 5)	--	75	160	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 400 \text{ V}, I_D = 8.0 \text{ A}, V_{\text{GS}} = 10 \text{ V}$	--	41	53	nC
Q_{gs}	Gate-Source Charge		--	6.5	--	nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)	--	17	--	nC

Drain-Source Diode Characteristics and Maximum Ratings

I_S	Maximum Continuous Drain-Source Diode Forward Current	--	--	8.0	A	
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	32	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_S = 8.0 \text{ A}$	--	--	1.4	V
t_{rr}	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}, I_S = 8.0 \text{ A}, dI_F / dt = 100 \text{ A}/\mu\text{s}$	--	390	--	ns
Q_{rr}	Reverse Recovery Charge	(Note 4)	--	4.2	--	μC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $L = 9.0\text{mH}$, $I_{AS} = 8.0\text{A}$, $V_{DP} = 50\text{V}$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{SP} \leq 8.0\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{DP} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature



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Typical Characteristics

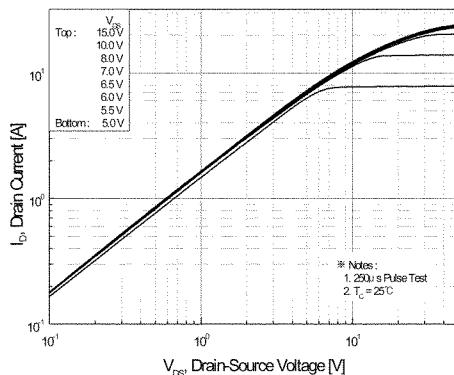


Figure 1. On-Region Characteristics

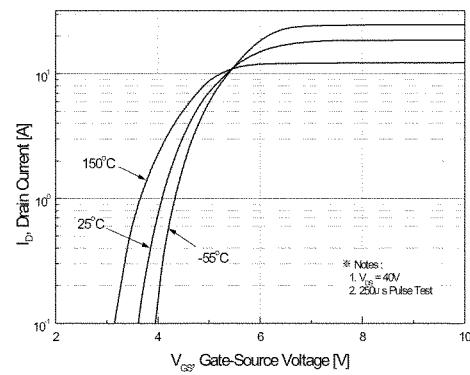


Figure 2. Transfer Characteristics

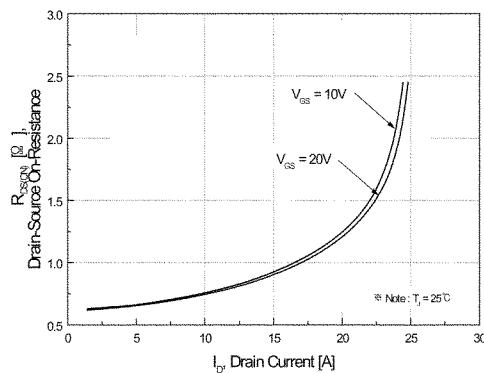


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

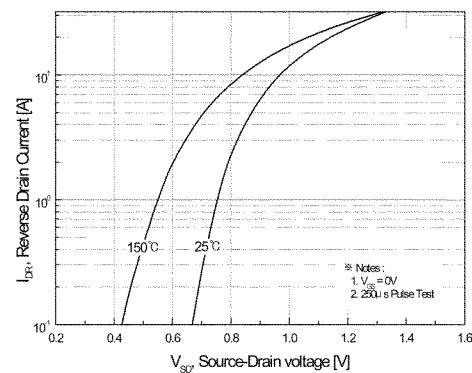


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

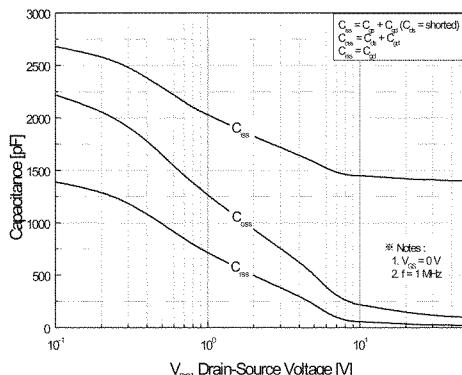


Figure 5. Capacitance Characteristics

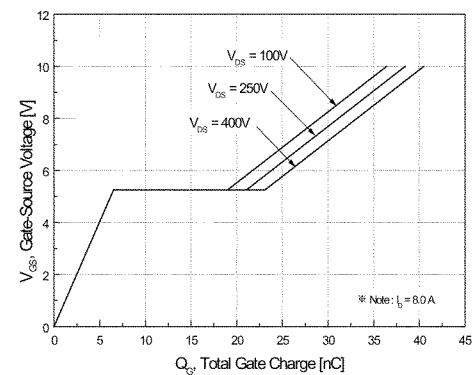


Figure 6. Gate Charge Characteristics



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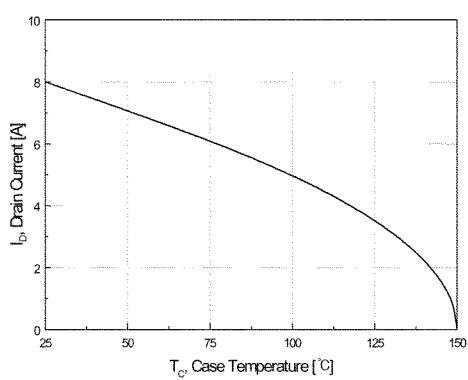
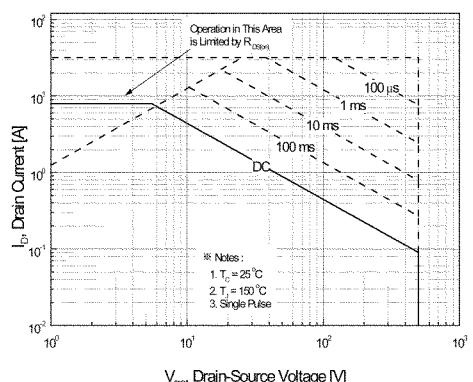
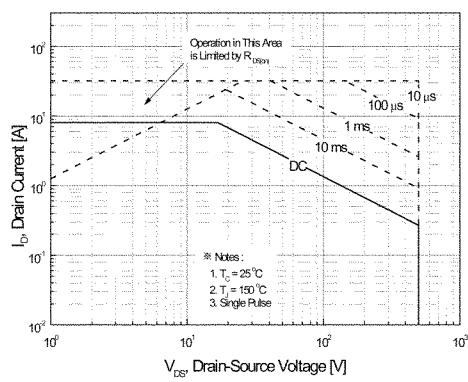
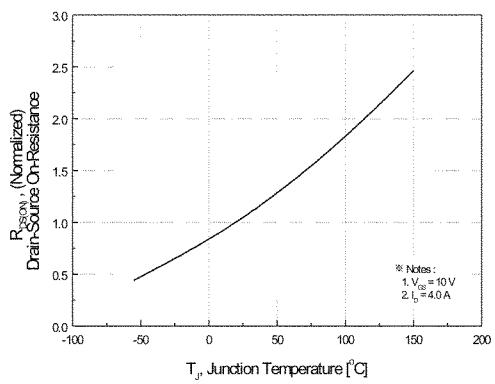
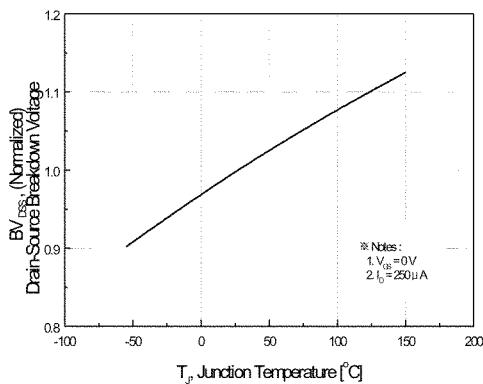
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Typical Characteristics

(Continued)





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IRF840B/IRFS840B

Typical Characteristics (Continued)

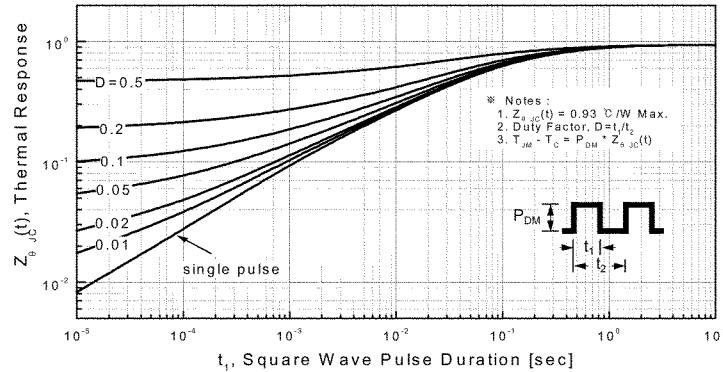


Figure 11-1. Transient Thermal Response Curve for IRF840B

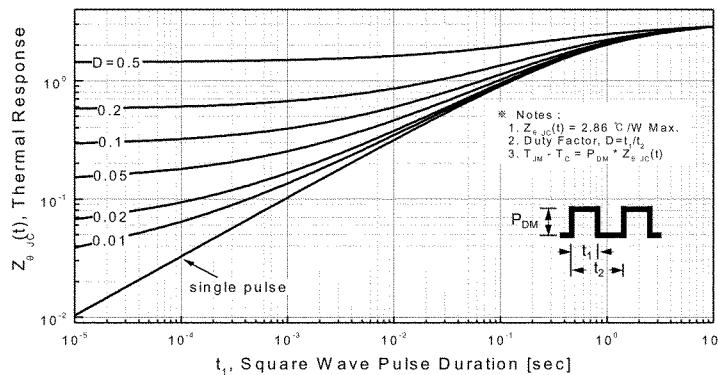


Figure 11-2. Transient Thermal Response Curve for IRFS840B



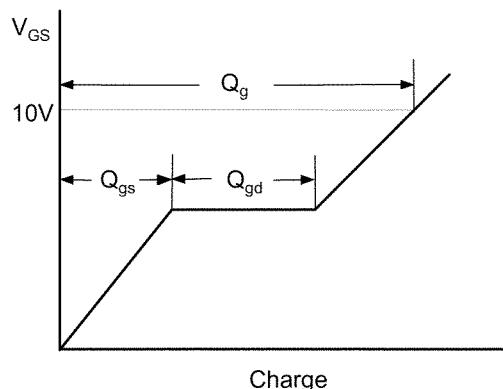
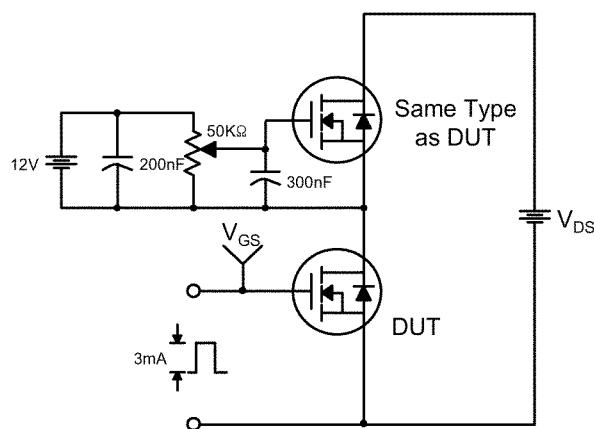
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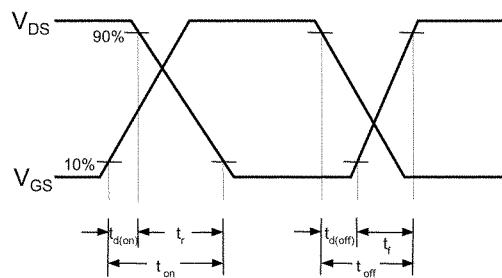
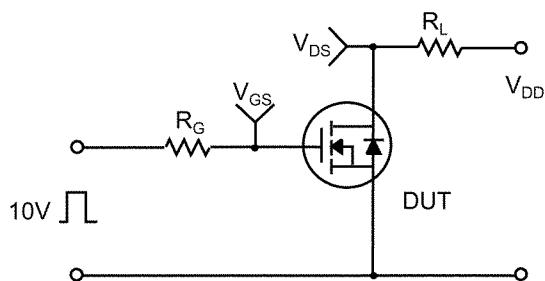
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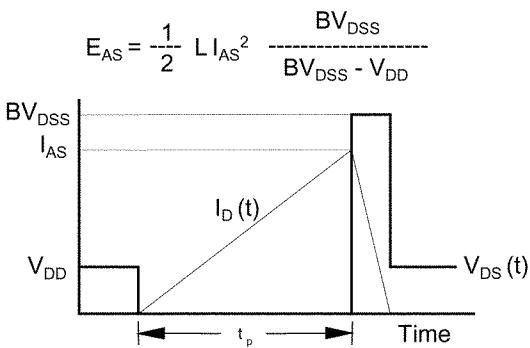
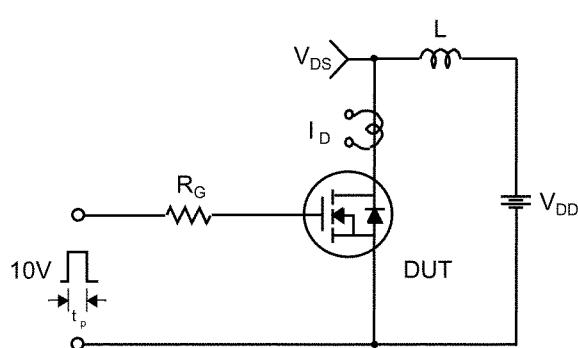
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms





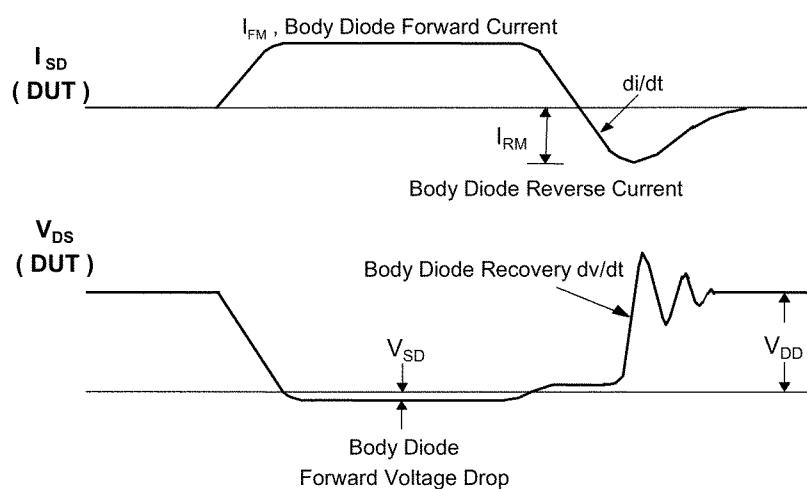
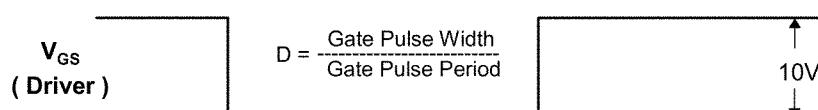
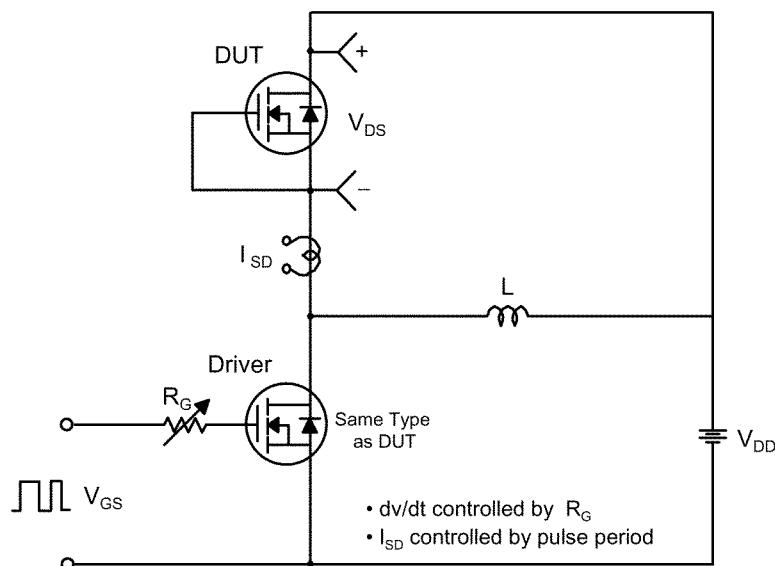
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Peak Diode Recovery dv/dt Test Circuit & Waveforms





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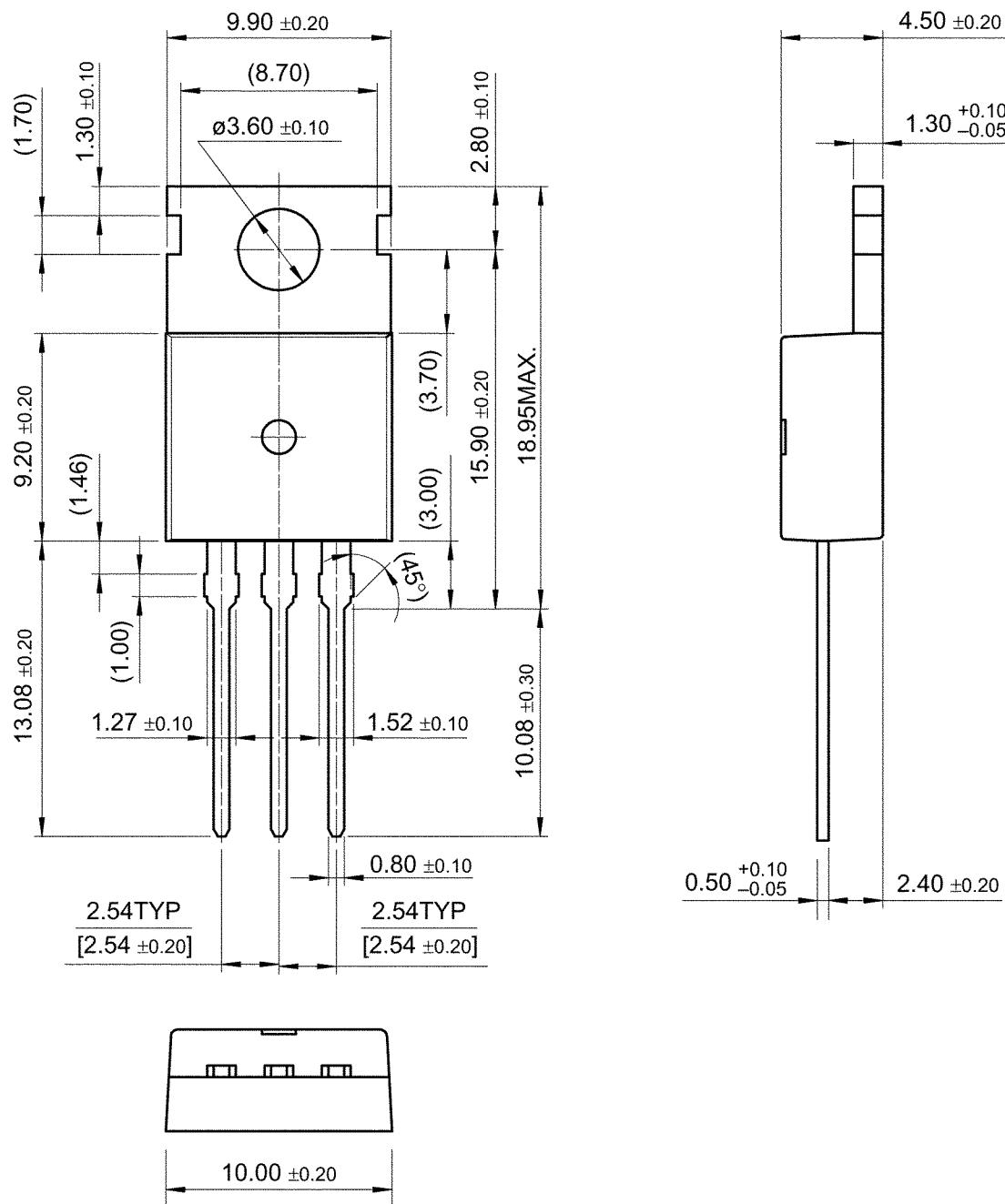
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Package Dimensions

TO-220

IRF840B/IRFSS840B



Dimensions in Millimeters



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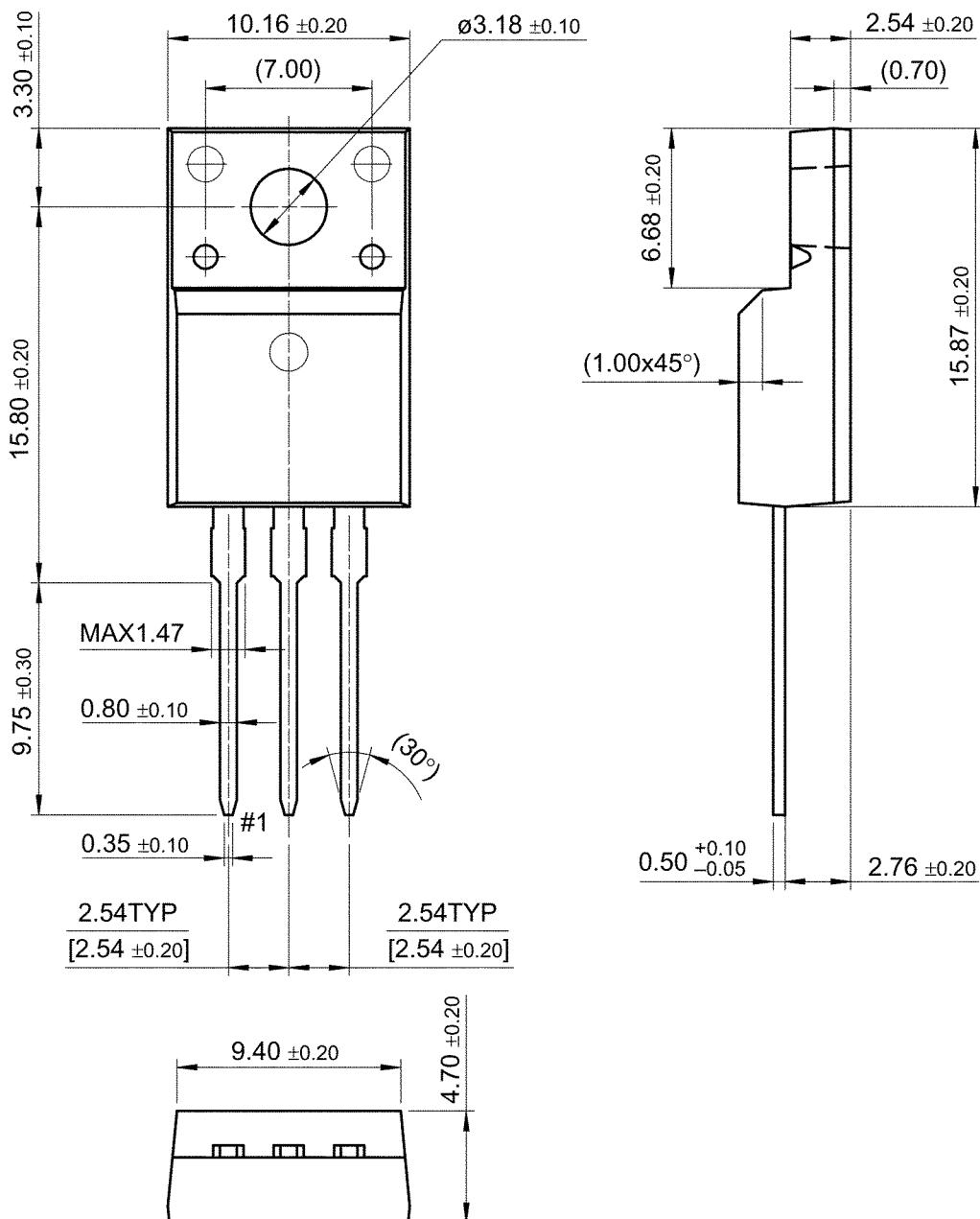
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IRF840B/IRFS840B

Package Dimensions (Continued)

TO-220F



Dimensions in Millimeters